

## Dielectric behavior in erbium-doped tellurite glass for potential high-energy capacitor

### ABSTRACT

The use of erbium ions,  $\text{Er}^{3+}$  to enhance the dielectric properties is investigated in tellurite glass system for the first time, to the best of our knowledge. A glass series of tellurite glass with chemical composition,  $\{[(\text{TeO}_2)_{70}(\text{B}_2\text{O}_3)_{30}]_{70}(\text{ZnO})_{30}\}_{100-y}(\text{Er}_2\text{O}_3)_y$  ( $y = 0, 0.005, 0.01, 0.02, 0.03, 0.04$  and  $0.05$ ) was fabricated via melt-quenched technique. The X-ray diffraction and Fourier transform infrared spectroscopy analysis proved the amorphous structure and the formation of nonbridging oxygen in the glass system. The  $\text{Er}^{3+}$  ions affect greatly to the dielectric constant,  $\epsilon'$  in which the dielectric constant,  $\epsilon'$  show high value at a lower frequency and higher temperature (above  $110^\circ\text{C}$ ). The reduction of dielectric constant,  $\epsilon'$  is found with the increment value of frequency, which corresponds to the formation of the hindrance effect on heavy dipoles caused by the mixed transition-ion effect. Meanwhile, the dielectric constant,  $\epsilon'$  is enhanced with the increase of temperature. The activation energy of the glass system is found to decrease, which is due to the high polarizability of  $\text{Er}^{3+}$  ions in the glass system. Based on these results, the erbium-doped tellurite glass is a potential kind of high-energy capacitor.

**Keyword:** Dielectric; Tellurite glass system; High-energy capacitor